Multivariate analysis for the $W \rightarrow \pi \gamma$ search



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Outline

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- 3. ROOT TMVA package
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CMS - the experiment and my part in it



- General-purpose detector with different detection layers
- Large international collaboration
- EP-UCM: Experimental Physics
 - department, CMS users group

$W \rightarrow \pi \gamma$ events

- Very rare BR < 10^{-5}
- Multiple variables to consider
 - > p_T^π (1)
 - ≻ E_Tγ(2)
 - $> p_{T}^{e/\mu}$ (3)
 - event missing energy (4)
 - ➢ nBjets (p_T>25GeV) (5)
 - \succ π relative isolation
 - \succ e/ μ relative isolation
 - ≫ Δφ(ℓ,π)



ROOT TMVA package



TMVA = Toolkit for MultiVariate Analysis

from TMVA Home

- Includes supervised learning algorithms for classification and regression
- My task was to determine which classification method best discriminates between signal and background for W $\rightarrow \pi\gamma$, and which of the variables matter
- For training and testing the MVA methods, I was given Monte Carlo signal and background events in TTrees containing the different input variables

Boosted decision trees (BDT)



MLP neural network (NN) Input Layer Hidden Layer Output Layer X_1 X_2 JANN X3 X_4 W_{01}^{2} W05 Bias Bias from TMVA Users Guide

Projective likelihood estimator (PDE)

$$y_{\mathcal{L}}(i) = \frac{\mathcal{L}_S(i)}{\mathcal{L}_S(i) + \mathcal{L}_B(i)}$$

$$\mathcal{L}_{S(B)}(i) = \prod_{k=1}^{n_{\text{var}}} p_{S(B),k}(x_k(i))$$

k-Nearest Neighbour (k-NN)



from TMVA Users Guide

ROC plots for BDT, MLP, PDE, and kNN methods, electron sample



BDT clearly performs the best for this selection

MLP performance is limited by our computing power

PDE and kNN perform similarly, as expected, as they both use probability density functions (PDFs)

Didn't use all the input variables

ROC plot BDT, electron channel

ROC plot BDT, electron channel



BDT score and event selection

- BDT gives each event a score between -1
 and 1 based on how "signal-like" it is
- Based on our MC sample's BDT score distribution we can choose an appropriate cut that gives us more signal and fewer background events
- Fluctuations in background distribution due to some low background statistics



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Conclusions and next steps

- ★ For the BDT the variables Δφ(ℓ,π) and e/µ relative isolation did not have much effect on performance → can make the training more robust by excluding them
- For the given sample of MC events the BDT method is most effective at discriminating signal and background
 - > PDE and kNN do fine but have intrinsic limits
 - > MLP is limited by computing resources
- ★ After this work, next question is, what is the cut on BDT score that maximizes significance? $Sig = \frac{N_S \cdot \boldsymbol{\varepsilon}_S}{\sqrt{N_S \cdot \boldsymbol{\varepsilon}_S + N_B \cdot \boldsymbol{\varepsilon}_B}}$

